# SJ-A2920 Series



Size, mm 9 x 14 I/O 4 J Lead Supply Voltage 3.3V / 5V

### Differential Positive ECL (DPECL) Fast Edge SJ-A2920 Series Rev K

Frequency Range: 50.0 MHz to 200.0 MHz

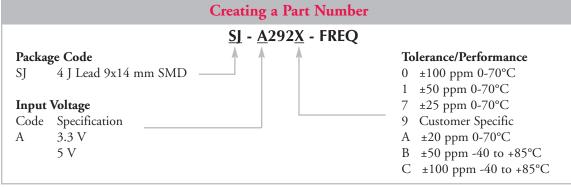
### **Description**

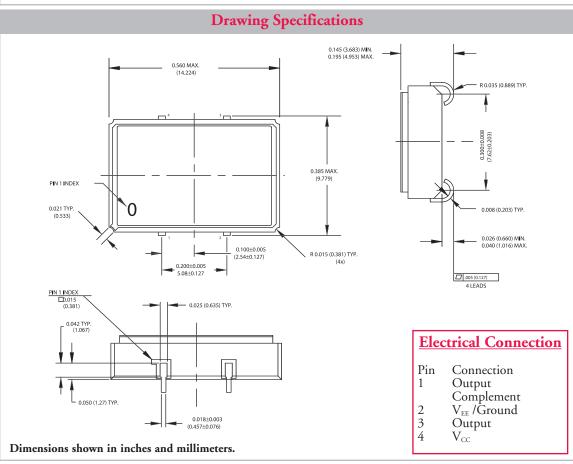
The SJ-A2920 Series of quartz crystal oscillators provide DPECL Fast Edge compatible signals. Systems designers may now specify space-saving, cost-effective packaged PECL oscillators to meet their timing require-

### **Features**

- High Reliability NEL HALT/HASS qualified for crystal oscillator start-up conditions
- Low jitter Wavecrest jitter characterization available
- Wide frequency range—50.0 MHz to 200.0 MHz
- User specified tolerance available
- Will withstand vapor phase temperatures of 253°C for 4 minutes maximum
- Space-saving alternative to discrete component oscillators
- High shock resistance, to 3000g

- 3.3 Volt operation
- Metal lid electrically connected to ground to reduce EMI
- Fast rise and fall times, <600 ps
- Overtone technology
- High Q crystal actively tuned oscillator circuit
- Power supply decoupling internalNo internal PLL avoids cascading PLL problems
- High frequencies due to proprietary design
- Gold plated leads—Solder dipped leads available upon request
- RoHS Compliant, Lead Free Construction (unless solder dipped leads are supplied)







For the most up to date specifications on each NEL product, log on to our websitewww.nelfc.com

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### **Operating Conditions and Output Characteristics**

<b>Electrical Characteris</b>	tics				
Parameter	<b>Symbol</b>	Conditions	Min	<b>Typical</b>	Max
Frequency	<b>-</b>	<del>_</del>	50.0 MHz		200.0 MHz
Duty Cycle	_	@V <sub>CC</sub> -1.29 V	45/55%		55/45%
Duty Cycle Logic 0 <sup>(2)</sup>	$V_{\scriptscriptstyle OL}$	<u> </u>	1.35 V		1.70 V
Logic 1 <sup>(2)</sup>	$V_{OH}$	<del>_</del>	2.28 V		2.56 V
Rise & Fall Time	$t_r$ , $t_f$ 20-	-80% $V_0$ with 50 ohm load to $V_{CC}$ -2	V —		600 psec
$\operatorname{Tpd}^{(4)}$		<del></del>	-200 psec		+200 psec
Jitter, RMS <sup>(5)</sup>	_	<del>_</del>	_		3 psec
Frequency Stability <sup>(1)</sup>	dF/F	Overall conditions including: voltage, calibration, temp., 10 yr aging, shock, vibration	-100 ppm	_	+100 ppm

### **General Characteristics**

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Parameter	Symbol	Conditions	Min	<b>Typical</b>	Max
Supply Voltage	$ m V_{cc}$	<del>_</del>	3.15 V	3.3 V	3.45 V
Supply Current	$I_{cc}$	50 ohm termination to 2.00 V below $V_{CC}$	0.0 mA		80 mA
Output Current	$I_{o}$	Low level Output Current	0.0 mA		±50.0 mA
Operating Temperature	$T_{\scriptscriptstyle A}$	<u> </u>	0°C		70°C
Storage Temperature	$T_s$	<del>_</del>	-55°C		125°C
Power Dissipation	$P_{\scriptscriptstyle \mathrm{D}}$	<del></del>			276 mW
Lead Temperature	$T_{\scriptscriptstyle  m L}$	Soldering, 10 sec.			300°C
Load	50 ohm to Vcc -	2 V or Thevenin Equivalent, Bias Required			
Start-up Time	$t_s$	_	_	2 ms	10 ms

### **Environmental and Mechanical Characteristics**

Mechanical Shock Per MIL-STD-202, Method 213, Condition E Thermal Shock Per MIL-STD-833, Method 1011, Condition A

Vibration 0.060" double amplitude 10 Hz to 55 Hz, 35g's 55 Hz to 2000 Hz

Soldering Condition 300°C for 10 seconds

Hermetic Seal Leak rate less than 1 x 10<sup>-8</sup> atm.cc/sec of helium

#### Footnotes:

1) Standard frequency stability (±20, ±25, ±50 ppm & others available).

2)  $V_{OL}$ ,  $V_{OH}$ , referenced to ground ( $V_{EE}$ ) with  $V_{CC}^{11} = 3.3 \text{ V}$ .

3) Jitter performance is frequency dependent. Please contact factory for full Wavecrest characterization. RMS jitter bandwidth of 12kHz to 20MHz.

4) Tpd is phase shift between the falling edge of pin 3 at 2.0 V and the rising edge of pin 1 at 2.01 V.

